

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10664635	NAKAMURA, MITSUHIRO
	Examiner	Art Unit
	Hoang, Hieu T	2152

SEARCHED

Class	Subclass	Date	Examiner
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SEARCH NOTES

Search Notes	Date	Examiner
EAST	10/9/2007	HH
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INTERFERENCE SEARCH

Class	Subclass	Date	Examiner